## Application/Control No. 10/700,438 Applicant(s)/Patent Under Reexamination HAZEYAMA ET AL. Examiner Lynne Edmondson Applicant(s)/Patent Under Reexamination HAZEYAMA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,422,452	07-2002	Yamamoto et al.	228/246
*	В	US-5,609,292	03-1997	Kohn, Harold	228/246
*	С	US-6,270,002	08-2001	Hayashi et al.	228/246
*	D	US-5,831,247	11-1998	Hidaka, Masao	219/388
*	E	US-6,460,755	10-2002	Inoue et al.	228/246
.*	F	US-6,533,160	03-2003	Bourrieres et al.	228/41
*	G	US-2002/0135064	09-2002	Hazeyama et al.	257/737
*	н	US-2003/0110626	06-2003	Cobbley et al.	29/840
*	- 1	US-6,709,469	03-2004	Link, Joseph	29/25.01
*	J	US-6,641,030	11-2003	Freeman et al.	228/246
*	К	US-6,112,975	09-2000	Lapastora, James	228/248.1
*	L	US-6,119,927	09-2000	Ramos et al.	228/254
*	М	US-2003/0121957	07-2003	Cobbley et al.	228/245

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	2001-135660-A	05-2001	Japan	Takahashi	
*	0	2001-156092-A	06-2001	Japan	Kubota Kimitaka	ŕ
*	Р	2001-077147-A	02-2001	Japan	Massiot Michel	
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	x	

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